Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10574445	STEER ET AL.
Examiner	Art Unit
YUK CHOW	2629

SEARCHED				
Class	Subclass	Date	Examiner	
345	76, 77, 205, 210, 211	3/12/2010	YC	
702	189	3/12/2010	YC	
257	59	3/12/2010	YC	

SEARCH NOTES		
Search Notes	Date	Examiner
drive transistor, drive voltage, interrupt, row driver, shift register, field period, duration.	3/12/2010	YC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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